AX-335N High Speed, 1kHz Digital Capacitance Checker

High-speed type with a built-in BCD parallel output



- Measuring range: $0 \sim 19.99 \,\mu$ F
- 5-terminal measurement method
- BCD parallel out available
- Comparison result by built-in comparator is open-collector output and displayed as LO, GO, HI by LED and buzzer

Specifications

Measuring range and Accuracy (at23°C ±5 °C) *D<0.5 parallel equivalent circuit

Range	Measuring range	Measuring voltage	Accuracy
0	0.00∼ 19.99pF		within $\pm 0.3\%$ of rdg ± 3 digit
1	0.0∼ 199.9pF		
2	0.000∼ 1.999nF		within $\pm 0.3\%$ of rdg ± 2 digit
3	0.00∼ 19.99nF	about 1V (r.m.s.)	
4	0.0∼ 199.9nF		
5	0.000∼1.999 μ F		
6	0.00∼19.99 μ F		

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Measuring frequency		within 1kHz ±0.1%, SINE wave				
C offset range		about 10pF				
Sampling time		[Remote start mode] 12.2msec.				
		[Free running mode] 45 times per second				
Maximum display		1999				
External bias		max.DC25V				
Comparator set range		0000∼1999 both HI and LO				
Indication of comparator's comparison result		LED indication LO/GO/HI and buzzer				
Control signal		•	t measurement signal:	"L" [OV] → "H" [DC12V] start :Open and "H" [DC12V] :Free run/"L" [OV] :Hold :LO/GO/HI:open collector:max.50V,100mA :EOC: open collector:max.50V, 100mA Termination signal:Fan-out 2		
Operation conditi	ion	[Temp.] +5°C~+40°C [Humidity] less than 85%				
Power supply		AC100V~240V selectable, 50/60Hz, about 20VA				
Outer dimension		about 260 (W) \times 90 (H) \times 250 (D) mm (excluding protruding parts such as rubber legs, etc.)				
Weight		about 2.6kg				